Searcn	notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/649,738	CHOI ET AL.	
Examiner	Art Unit	
Mike Qi	2871	

	SEAR	CHED	
Class	Subclass	Date	Examiner
349	123,132 133,134 172,99 100	1/3/2006	ZQQ
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East search US-PGPUB;USPAT;USOCR; EPO;JPO;DERWENT;IBM_TDB; update search (see search history printout)	1/3/2006	ZQQ
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